

**SCOPE: 8TH-ORDER CONTINUOUS-TIME ACTIVE FILTERS**

| <u>Device Type</u> | <u>Generic Number</u> |
|--------------------|-----------------------|
| 01                 | MAX274AMYG/883B       |
| 02                 | MAX274BMYG/883B       |

**Case Outline(s).** The case outlines shall be designated in Mil-Std-1835 and as follows:

| <u>Outline Letter</u> | <u>Mil-Std-1835</u> | <u>Case Outline</u> | <u>Package Code</u> |
|-----------------------|---------------------|---------------------|---------------------|
| YB                    | CDIP2-T24           | 24 Lead Sidebrazed  | Y24                 |

**Absolute Maximum Ratings**

|  |  |
|--|--|
| V+ to V- .....   | -0.3V, 12V                                 |
| Input Voltage to GND (any input) .....                   | V <sup>-</sup> -0.3V, V <sup>+</sup> +0.3V |
| Lead Temperature (soldering, 10 seconds) .....           | +300°C                                     |
| Storage Temperature .....                                | -65°C to +150°C                            |
| Continuous Power Dissipation .....                       | T <sub>A</sub> =+70°C                      |
| 24 pin Sidebrazed (derate 14.29mW/°C above +70°C) .....  | 1143mW                                     |
| Junction Temperature T <sub>J</sub> .....                | +150°C                                     |
| Thermal Resistance, Junction to Case, $\theta_{JC}$ :    |  |
| 24 pin Sidebrazed .....                                  | 25°C/W                                     |
| Thermal Resistance, Junction to Ambient, $\theta_{JA}$ : |  |
| 24 pin Sidebrazed .....                                  | 70°C/W                                     |

**Recommended Operating Conditions**

|   |                 |
|---|-----------------|
| Ambient Operating Range (T <sub>A</sub> ) ..... | -55°C to +125°C |
|---|-----------------|

Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**TABLE 1. ELECTRICAL TESTS:**

| TEST                                  | Symbol            | CONDITIONS   |       | Group A Subgroup | Device type  | Limits Min   | Limits Max | Units    |
|---------------------------------------|-------------------|--|-------|------------------|--------------|--------------|------------|----------|
|                                       |                   | -55 °C ≤ T <sub>A</sub> ≤ +125 °C<br>V <sub>+</sub> =5V, V <sub>-</sub> =-5V<br>Unless otherwise specified |       |                  |              |              |            |          |
| <b>FILTER CHARACTERISTICS</b>         |                   |  |       |                  |              |              |            |          |
| Center-Frequency Accuracy             | F <sub>o</sub>    |  |       | 1,2,3            | 01<br>02     | -1.0<br>-1.4 | 1.0<br>1.4 | %        |
| Q Accuracy-Unadjusted                 | F <sub>o</sub>    |  |       | 1,2,3            | 01<br>02     | -10<br>-15   | 10<br>15   | %        |
| <b>DC CHARACTERISTICS</b>             |                   |  |       |                  |              |              |            |          |
| DC Lowpass Gain Accuracy              | H <sub>OLP</sub>  | Assume ideal resistors   |       | 1,2,3            | 01<br>02     | -2.0<br>-3.0 | 2.0<br>3.0 | %        |
| Offset Voltage at Outputs             | V <sub>OS</sub>   | LPO <sub>-</sub>   | 1,2,3 | 01<br>02         | -200<br>-300 | 200<br>300   | mV         |          |
|                                       |                   | BPO <sub>-</sub>   |       |                  |              |              |            | 01<br>02 |
| Leakage Current at FC Pin             | I <sub>FC</sub>   |  |       | 1,2,3            | 01,02        | -10          | 10         | μA       |
| <b>DYNAMIC FILTER CHARACTERISTICS</b> |                   |  |       |                  |              |              |            |          |
| Output Voltage Swing                  | V <sub>OUT</sub>  | LPO <sub>-</sub> , BPO <sub>-</sub> , R <sub>LOAD</sub> =5kΩ   |       | 1,2,3            | All          | ±3.25        |            | V        |
| <b>POWER REQUIREMENTS</b>             |                   |  |       |                  |              |              |            |          |
| Supply Voltage Range                  | V <sub>SUPP</sub> |  |       | 1,2,3            | All          | ±2.37        | ±5.5       | V        |
| Supply Current                        | I <sub>CC</sub>   | For V <sub>+</sub> , V <sub>-</sub>  |       | 1,2,3            | All          |              | ±30        | mA       |

| Package        | ORDERING | INFORMATION:    |
|----------------|----------|-----------------|
| 24pin Sidebraz | 01       | MAX274AMYG/883B |
| 24pin sidebraz | 02       | MAX274BMYG/883B |

|    | 24 pin Sidebraz |    |      |
|----|-----------------|----|------|
| 1  | LPOA            | 13 | LPOC |
| 2  | INA             | 14 | INC  |
| 3  | BPIA            | 15 | BPIC |
| 4  | BPOA            | 16 | BPOC |
| 5  | V+              | 17 | V-   |
| 6  | LPIA            | 18 | LPIC |
| 7  | LPIB            | 19 | LPID |
| 8  | FC              | 20 | GND  |
| 9  | BPOB            | 21 | BPOD |
| 10 | BPIP            | 22 | BPID |
| 11 | INB             | 23 | IND  |
| 12 | LPOB            | 24 | LPOD |

## QUALITY ASSURANCE

Sampling and inspection procedures shall be in accordance with MIL-Prf-38535, Appendix A as specified in Mil-Std-883.

Screening shall be in accordance with Method 5004 of Mil-Std-883. Burn-in test Method 1015:

1. Test Condition, A, B, C, or D.
2. TA = +125°C minimum.
3. Interim and final electrical test requirements shall be specified in Table 2.

Quality conformance inspection shall be in accordance with Method 5005 of Mil-Std-883, including Groups A, B, C, and D inspection.

Group A inspection:

1. Tests as specified in Table 2.
2. Selected subgroups in Table 1, Method 5005 of Mil-Std-883 shall be omitted.

Group C and D inspections:

- a. End-point electrical parameters shall be specified in Table 1.
- b. Steady-state life test, Method 1005 of Mil-Std-883:
  1. Test condition A, B, C, D.
  2. TA = +125°C, minimum.
  3. Test duration, 1000 hours, except as permitted by Method 1005 of Mil-Std-883.

**TABLE 2. ELECTRICAL TEST REQUIREMENTS**

| Mil-Std-883 Test Requirements                                | Subgroups<br>per Method 5005, Table 1 |
|--|---------------------------------------|
| Interim Electric Parameters<br>Method 5004                   | 1                                     |
| Final Electrical Parameters<br>Method 5005                   | 1*, 2, 3                              |
| Group A Test Requirements<br>Method 5005                     | 1, 2, 3                               |
| Group C and D End-Point Electrical Parameters<br>Method 5005 | 1                                     |

\* PDA applies to Subgroup 1 only.